

Search Notes**Application/Control No.**

10/706,530

Examiner

Mark Eashoo, Ph.D.

Applicant(s)/Patent under Reexamination

SETH ET AL.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
428	100		
24	452		
264	145		
	167		
	156		
	288.4		
	288.8		
	342e		
	211.17	6/2/2005	ME

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search (eDAN)	6/2/2005	ME

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner